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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

	DATE	EXMR
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	5/16/2006	
Google	5/16/2006	RSD
IEEEExplore	5/16/2006	RSD
Inventors' name search	5/15/2006	RSD